Substitute Form PTO-1449	U.S. Department of Commerce	Attorney's Docket No.	Application No. 09/718,155	
(Modified)	Patent and Trademark Office	10449-026001		
by Ap		Applicant Koji Hayashi		
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(37 CFR §1.88(b))		November 21, 2000	2653	

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KL	AH	2000-40302	02/08/00	Japan			х	
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KL	AJ	10-63433	03/06/98	Japan			х	
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Substitute Form PTG-1449
Sheet 1 of 1

Application No. 10449-026001 09/718,155

Information Disclosure Statement Koji Hayashi

(Use several-sheets if necessary)

Filing Date Group Art Unit

November 21, 2000

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Substitute Form PTO-1449 U.S. Department of Commerce (Modified) Patent and Trademark Office		Attorney's Docket No. 10449-026001	Application 09/71	Application No. 09/718/53 PE		
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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 10449-026001	Application No. 09/718,155	
Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Koji Hayashi		
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	Substitute Disclosure Form (PTO-1449)

Substitute Form RTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office

Application No. Attorney's Docket No. 10449-026001 09/718,155

Applicant 1 Koji Hayashi

Information Disclosure Statement
by Applicant
(Use several sheets if necessary)

Filing Date

November 21, 2000

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Modified Form PTO-1449	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 10449-026001	Application No. 09/718,155	
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KL	AA	6,084,731	Jul. 4, 2000	Uchida et al.				
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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office			
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		AB	6,715,211	08/10/04	Tsukihashi				
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